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(3) s

Schematic diagram

PTI€ÞF€SÆ

D

Marking and pin assignment

TO-252-2L top view

WW

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(1) G 아

N-Channel Enhancement Mode Power MOSFET

Description

The PTI \bigoplus F \in S^ÁA uses advanced trench technology and design to provide excellent R_{DS(ON)} with low gate charge. It can be used in a wide variety of applications.

General Features

- $V_{DS} = 100V, I_D = 40A$ $R_{DS(ON)} < 17m\Omega @ V_{GS} = 10V$ (Typ:14m Ω)
- Special process technology for high ESD capability
- High density cell design for ultra low Rdson
- Fully characterized avalanche voltage and current
- Good stability and uniformity with high E_{AS}
- Excellent package for good heat dissipation

Application

- Power switching application
- Hard switched and high frequency circuits
- Uninterruptible power supply

100% UIS TESTED!

100% ΔVds TESTED!

Package Marking and Ordering Information

| Device Marking | Device | Device Package | Reel Size | Tape width | Quantity |
|----------------|-----------|----------------|-----------|------------|----------|
| PT I €ÞF€SÄ | PTI€ÞF€SÆ | TO-252-2L | - | - | - |

Absolute Maximum Ratings (T_c=25[°]Cunless otherwise noted)

| Parameter | Symbol | Limit | Unit |
|--|-----------------------|------------|------|
| Drain-Source Voltage | Vds | 100 | V |
| Gate-Source Voltage | Vgs | ±20 | V |
| Drain Current-Continuous | Ι _D | 40 | А |
| Drain Current-Continuous(T _C =100°C) | I _D (100℃) | 28 | A |
| Pulsed Drain Current | I _{DM} | 160 | A |
| Maximum Power Dissipation | PD | 140 | W |
| Derating factor | - | 0.94 | W/℃ |
| Single pulse avalanche energy (Note 5) | E _{AS} | 520 | mJ |
| Operating Junction and Storage Temperature Range | T_J,T_STG | -55 To 175 | °C |





Thermal Characteristic

| Thermal Resistance, Junction-to-Case | (Noto 2) |
|--------------------------------------|----------|
| | |

1.07

 $R_{\theta JC}$

°C/W

Electrical Characteristics (Tc=25 $^{\circ}$ C unless otherwise noted)

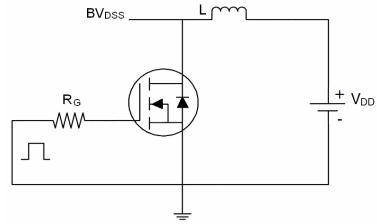
| Parameter | Symbol | Condition | Min | Тур | Max | Unit |
|------------------------------------|---------------------|--|-----|------|------|------|
| Off Characteristics | | | | | | |
| Drain-Source Breakdown Voltage | BV _{DSS} | V _{GS} =0V I _D =250µA | 100 | 110 | - | V |
| Zero Gate Voltage Drain Current | I _{DSS} | V _{DS} =100V,V _{GS} =0V | - | - | 1 | μA |
| Gate-Body Leakage Current | I _{GSS} | V _{GS} =±20V,V _{DS} =0V | - | - | ±100 | nA |
| On Characteristics (Note 3) | | | | | | |
| Gate Threshold Voltage | V _{GS(th)} | V _{DS} =V _{GS} ,I _D =250µA | 2 | 3 | 4 | V |
| Drain-Source On-State Resistance | R _{DS(ON)} | V _{GS} =10V, I _D =28A | - | 14 | 17 | mΩ |
| Forward Transconductance | g fs | V _{DS} =25V,I _D =28A | 32 | - | - | S |
| Dynamic Characteristics (Note4) | | | | | | |
| Input Capacitance | C _{lss} | | - | 3400 | - | PF |
| Output Capacitance | C _{oss} | V _{DS} =30V,V _{GS} =0V, F=1.0MHz | - | 290 | - | PF |
| Reverse Transfer Capacitance | C _{rss} | | - | 221 | - | PF |
| Switching Characteristics (Note 4) | | | | | | |
| Turn-on Delay Time | t _{d(on)} | | - | 15 | - | nS |
| Turn-on Rise Time | tr | VDD=30V,ID=2A,RL=15Ω, | - | 11 | - | nS |
| Turn-Off Delay Time | t _{d(off)} | RG=2.5Ω,VGS=10V | - | 52 | - | nS |
| Turn-Off Fall Time | t _f | | - | 13 | - | nS |
| Total Gate Charge | Qg | | - | 94 | - | nC |
| Gate-Source Charge | Q _{gs} | ID=30A,VDD=30V,VGS=10V | - | 16 | - | nC |
| Gate-Drain Charge | Q _{gd} | | - | 24 | - | nC |
| Drain-Source Diode Characteristics | | | | | | |
| Diode Forward Voltage (Note 3) | V _{SD} | V _{GS} =0V,I _S =28A | - | 0.85 | 1.2 | V |
| Diode Forward Current (Note 2) | Is | | - | - | 40 | А |
| Reverse Recovery Time | t _{rr} | TJ = 25°C, IF = 28A | - | 33 | | nS |
| Reverse Recovery Charge | Qrr | di/dt = 100A/µs(Note3) | - | 54 | | nC |
| Forward Turn-On Time | t _{on} | Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD) | | | | |

Notes:

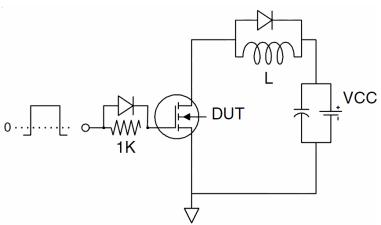
- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- **2.** Surface Mounted on FR4 Board, $t \le 10$ sec.
- **3.** Pulse Test: Pulse Width \leq 300µs, Duty Cycle \leq 2%.
- 4. Guaranteed by design, not subject to production
- **5.** EAS condition: $Tj=25^{\circ}C$, $V_{DD}=50V$, $V_{G}=10V$, L=0.5mH, $Rg=25\Omega$



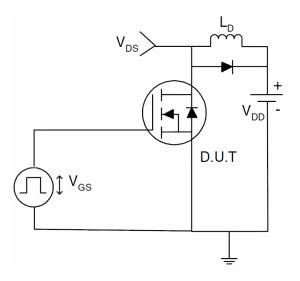
Test Circuit 1) E_{AS} test Circuit



2) Gate charge test Circuit

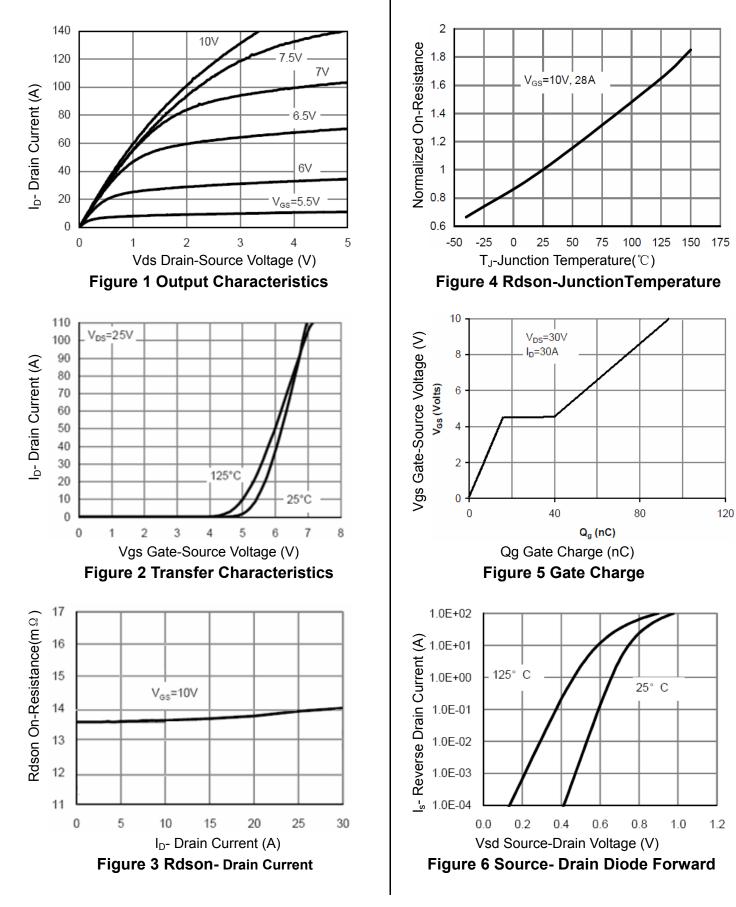


3) Switch Time Test Circuit



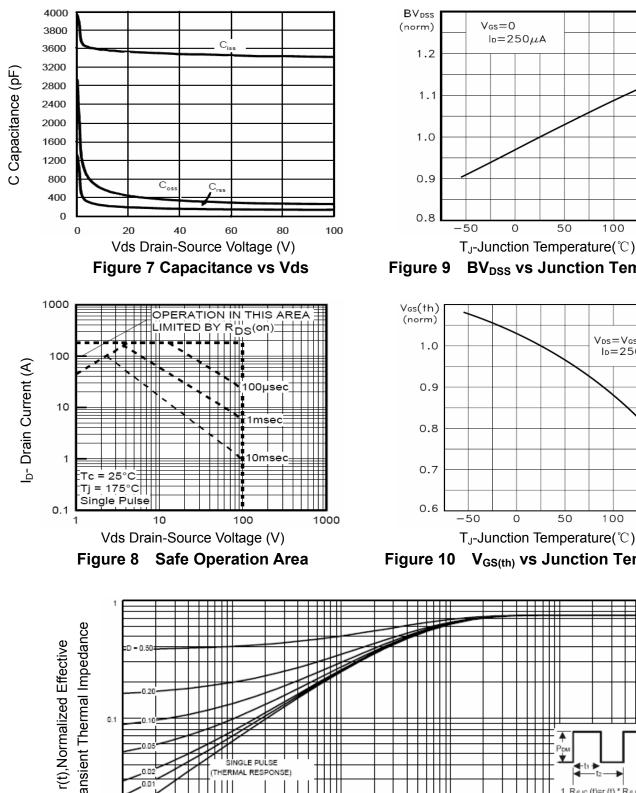


Typical Electrical and Thermal Characteristics (Curves)









BV_{DSS} vs Junction Temperature

50

100

TJ(°C)

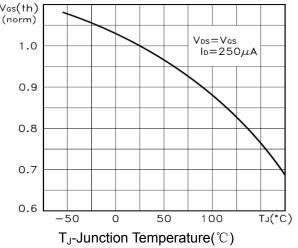
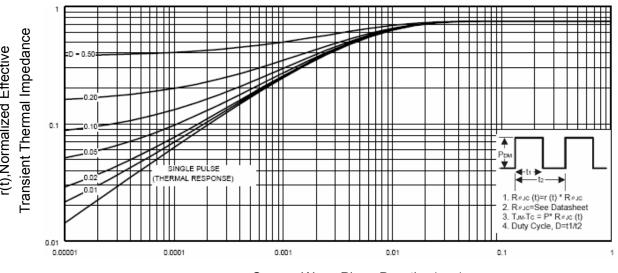


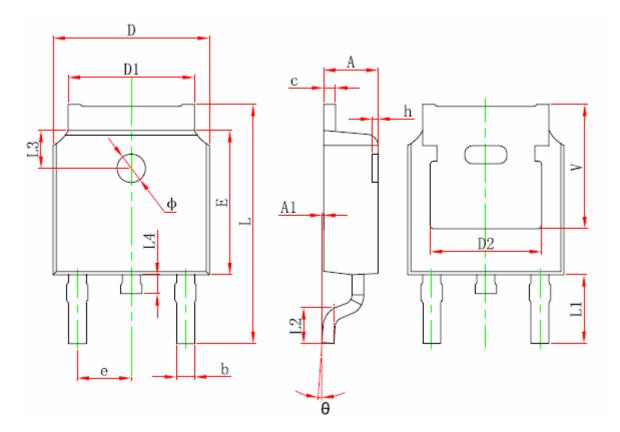
Figure 10 V_{GS(th)} vs Junction Temperature



Square Wave Pluse Duration(sec) Figure 11 Normalized Maximum Transient Thermal Impedance



TO-252-2L Package Information



| Symbol | Dimensions | In Millimeters | Dimensions In Inches | | |
|--------|------------|----------------|----------------------|-------|--|
| | Min. | Max. | Min. | Max. | |
| A | 2.200 | 2.400 | 0.087 | 0.094 | |
| A1 | 0.000 | 0.127 | 0.000 | 0.005 | |
| b | 0.660 | 0.860 | 0.026 | 0.034 | |
| с | 0.460 | 0.580 | 0.018 | 0.023 | |
| D | 6.500 | 6.700 | 0.256 | 0.264 | |
| D1 | 5.100 | 5.460 | 0.201 | 0.215 | |
| D2 | 4.830 | REF. | 0.190 REF. | | |
| E | 6.000 | 6.200 | 0.236 | 0.244 | |
| е | 2.186 | 2.386 | 0.086 | 0.094 | |
| L | 9.800 | 10.400 | 0.386 | 0.409 | |
| L1 | 2.900 | REF. | 0.114 REF. | | |
| L2 | 1.400 | 1.700 | 0.055 | 0.067 | |
| L3 | 1.600 | REF. | 0.063 REF. | | |
| L4 | 0.600 | 1.000 | 0.024 | 0.039 | |
| Φ | 1.100 | 1.300 | 0.043 | 0.051 | |
| θ | 0° | 8° | 0° | 8° | |
| h | 0.000 | 0.300 | 0.000 | 0.012 | |
| V | 5.350 | REF. | 0.211 REF. | | |



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